## Notice of References Cited Application/Control No. 10/699,046 Examiner BRIAN P. YENKE Applicant(s)/Patent Under Reexamination KAWASHIMA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	Α	US-5,099,318	03-1992	Tsukagoshi et al.	348/779
X	В	US-2003/0142242	07-2003	Yoon et al.	348/744
X	С	US-5,353,070	10-1994	Mitani et al.	348/781
X	D	US-6,797,366	09-2004	Hanson et al.	428/201
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-		·	
	К	US-			
	L	US-			
	М	US-			·

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.